	B JUN 0 1 200	Decir.						
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) June 1, 2004			ATTY DOCKET NO. 03500.017377	APPLICATION NO. 10/614,159				
			APPLICANT KEIJI TOMIZAWA ET AL.					
			FILING DATE July 8, 2003					
		T	U.S. PATENT DOCUMENTS	-				
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
So	4,587,534	05/1986	Saito et al.		_			
A	2001/0050704 A1	12/2001	Tachihara et al.					
FOREIGN PATENT DOCUMENTS								
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
A	JP 4-29850	01/1992	Japan			Abstract		
Ag	EP 0 770 487	05/1997	EPO			In English		
25	EP 1 167 471	01/2002	EPO			In English		
	OTH	EK DOCUMENT(S	S) (Including Author, Title, Date, Pertinent Pages, E	itc.)				
								
EXAMINER	Thely		DATE CONSIDERED 11/2	3/04				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicants.

Sheet 1 of 1

DWP/tmc

FORM PTO 1449 (modified) P E U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO. 03500.017377	APPLICATION NO. 10/614,159						
O PATENT AND TRADEMARK OFFICE			APPLICANT KEIJI TOMIZAWA ET AL.							
SEP 2 6 LIST OPREFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			FILING DATE		GROUP					
September 26, 2003			July 8, 2003 Unassigned 2853							
			J.S. PATENT DOCUMENTS	T	<u> </u>					
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE				
Sto	5,218,376	06/1993	Asai			7				
So	6,137,510	10/2000	Sato et al.							
B	6,286,933 B1	09/2001	Murakami et al.							
S	6,350,016 B1	02/2002	Tachihara et al.							
SI	6,439,696 B1	08/2002	Murakami et al.							
28	6,443,561 B1	09/2002	Murakami							
18	6,520,626 B1	02/2003	Murakami							
Ap.	6,540,335 B2	04/2003	Touge et al.							
B	2002/0054181 A1	05/2002	Murakami							
20	2002/0196299 A1	12/2002	Murakami							
Do	2003/0058305 A1	03/2003	Murakami et al.							
8	2003/0067508 A1	04/2003	Mizutani et al.	11						
FOREIGN PATENT DOCUMENTS										
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT				
100	JP 54-161935	12/1979	Japan			Abstract				
100	JP 61-185455	08/1986	Japan			Abstract				
A	JP 61-249768	11/1986	Japan		X	Abstract				
S	JP 4-10940	01/1992	Japan			Abstract*				
A	JP 4-10941	01/1992	Japan	<u>/</u>		Abstract*				
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
*Note: U.S. counterpart, Patent No. 5,218,376, is also enclosed.										
EXAMINER Alul DATE CONSIDERED 11/23/64 *EXAMINER: Initial if reference appointment whether or not citation is in conformance with MREP 600: Draw line through citation if not in ordiformance and as assistant. Include comy of this										

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicants.

Sheet 1 of 1

DWP/tmc DC_Main 144948v1